

TEST REPORT

 CTK Co., Ltd. The Prime Leader of Global Regulatory Certification	CTK Co., Ltd. (Ho-dong), 113, Yejik-ro, Cheoin-gu, Yongin-si, Gyeonggi-do, Korea Tel: +82-31-339-9970 Fax: +82-31-624-9501	Report No.: CTK-2017-01831 Page (1) / (31) Pages	
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1. Client

- Name : SOLUM CO.,LTD.
- Address : 4,5,6th F, 357, Guseong-ro, Giheung-gu, Gyeonggi-do, Yongin-si, Republic of Korea
- Data of Receipt : 2017-09-04

2. Manufacturer

- Name : SOLUM CO.,LTD.
- Address : 4,5,6th F, 357, Guseong-ro, Giheung-gu, Gyeonggi-do, Yongin-si, Republic of Korea

3. Use of Report : For FCC Certification

4. Test Sample / Model: ESL LABEL / TG-GR75

5. Date of Test : 2017-09-18 to 2017-09-25

6. Test Standard(method) used : FCC 47 CFR part 15 subpart C 15.247

7. Testing Environment: Temp.: (23 ± 1) °C, Humidity: (51 ± 3) % R.H.

8. Test Results : Compliance

The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This Test Report cannot be reproduced, except in full.

Affirmation	Tested by Bongseok, Kim: (Signature) 	Technical Manager Young-taek, Lee: (Signature) 
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2017-09-26

Republic of KOREA **CTK Co., Ltd.**



CTK Co., Ltd.
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Report No.:
CTK-2017-01831
Page (2) / (31) Pages

REPORT REVISION HISTORY

Date	Revision	Page No
2017-09-26	Issued (CTK-2017-01831)	all

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1. General Product Description

1.1 Client Information

Company	SOLUM CO.,LTD.
Contact Point	A-Tower 6th Floor, 357 Guseong-ro,Giheung-gu,Yongin-si, Gyeonggi-do,Republic of Korea (Zip 16914)
Contact Person	Name : Kim Jun Young E-mail : jy.kim1216@solu-m.com Tel : +81 31-8006-0960

1.2 Product Information

FCC ID	2AFWN-TG-GR75
Product Description	ESL LABEL
Model name	TG-GR75
Variant model	TG-GR750BN (TG-GR75 and TG-GR750BN are no technical difference from each model only except for model name because of marketing purposes.)
Operating Frequency	2 405 MHz - 2 480 MHz (DSSS)
RF Output Power	-2.78 dBm (0.527 mW)
Antenna Specification	Antenna type : PCB Antenna Peak Gain : -0.69 dBi
Number of channels	16
Channel Spacing	5 MHz
Type of Modulation	OQPSK
Power Source	DC 3.0 V (Coin Battery CR2450)
RF Power setting in Test SW	Initial value

1.3 Peripheral Devices

- For Radiated Measurement

Device	Manufacturer	Model No.	Serial No.
Notebook Computer	Dell	Dell LBL P/N PG967 A02	6L567BX
Adapter	Dell	HA65NS0-00	A02

- For Conducted Measurement

Device	Manufacturer	Model No.	Serial No.
Notebook Computer	SAMSUNG	NT-R540	NT-R540-PA33
Adapter	SAMSUNG	NT01	09708530

2. Facility and Accreditations

2.1 Test Facility

The measurement facility is located at (Ho-dong), 113, Yejik-ro, Cheoin-gu, Yong-in-si, Gyeonggi-do, Korea.

2.2 Laboratory Accreditations and Listings

Country	Agency	Scope of Accreditation	Registration Number	Logo
USA	FCC	FCC Part 15 & 18 EMI (Electromagnetic Interference / Emission)	805871	
CANADA	IC	IC EMI (3/10m test site)	8737A-2	
JAPAN	VCCI	VCCI V-3 EMI (Electromagnetic Interference / Emission)	C-986 T-1843 R-3627 G-387	
KOREA	MSIP	EMI (Electromagnetic Interference / Emission) EMS (Electromagnetic Susceptibility / Immunity)	KR0025	

2.3 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less. All test equipment calibrations are traceable to the Korea Research Institute of Standards and Science (KRISS), therefore, all test data recorded in this report is traceable to KRISS.

3. Test Specifications

3.1 Standards

Section in RSS	Requirement(s)	Status (Note 1)	Test Condition
15.247(a)	6 dB Bandwidth	C	Conducted
15.247(e)	Transmitter power spectral density	C	
15.247(b)	Maximum peak conducted output power	C	
15.247(d)	Unwanted emission	C	
15.209	Transmitter emission	C	Radiated
15.207	AC Conducted Emission	NA(Note 3)	Line Conducted
<u>Note 1:</u> C=Complies NC=Not Complies NT=Not Tested NA=Not Applicable			
<u>Note 2:</u> The data in this test report are traceable to the national or international standards.			
<u>Note 3:</u> The equipment is operated on battery power only.			
<u>Note 4:</u> The sample was tested according to the following specification: FCC Part 15.247, ANSI C63.10-2013			
<u>Note 5:</u> The tests were performed according to the method of measurements prescribed in KDB No.558074.			

3.2 Mode of operation during the test

The EUT is operated in a manner representative of the typical of the equipments. During at testing, system components were manipulated within the confines of typical usage to maximize each emission. All modulation modes were tests. The results are only attached worst cases.

Test Frequency

Lowest channel	Middle channel	Highest channel
2 405 MHz	2 445 MHz	2 480 MHz

Test mode

Modulation	Duty Cycle
OQPSK	100 %

3.3 Maximum Measurement Uncertainty

The value of the measurement uncertainty for the measurement of each parameter.
 Coverage factor $k = 2$, Confidence levels of 95 %

Description	Uncertainty
Conducted RF Output Power	1.5 dB
Occupied Bandwidth	0.1 MHz
Unwanted Emission(conducted)	3.0 dB
Radiated Emissions ($f \leq 1$ GHz)	4.0 dB
Radiated Emissions ($f > 1$ GHz)	5.0 dB

4. Technical Characteristic Test

4.1 6dB Bandwidth

Test Procedures(ANSI C63.10-2013 6.9.2)

Measure the maximum width of the emission that is constrained by the frequencies associated with the two outermost amplitude points (upper and lower frequencies) that are attenuated by 6 dB relative to the maximum level measured in the fundamental emission.

Test Procedures(ANSI C63.10-2013 6.9.3)

The occupied bandwidth is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers are each equal to 0.5% of the total mean power of the given emission.

Use the 99% power bandwidth function of the instrument and report the measured bandwidth.

Test Settings :

Center frequency = the highest, middle and the lowest channels

- a) RBW = 100 kHz
- b) VBW $\geq 3 \times$ RBW
- c) Detector = peak
- d) Trace mode = Max hold
- e) Sweep = auto couple
- f) Allow trace to fully stabilize
- g) Measure the maximum width of the emission that is constrained by the frequencies associated with the two outermost amplitude points (upper and lower frequencies) that are attenuated by 6 dB relative to the maximum level measured in the fundamental emission.

Limit :

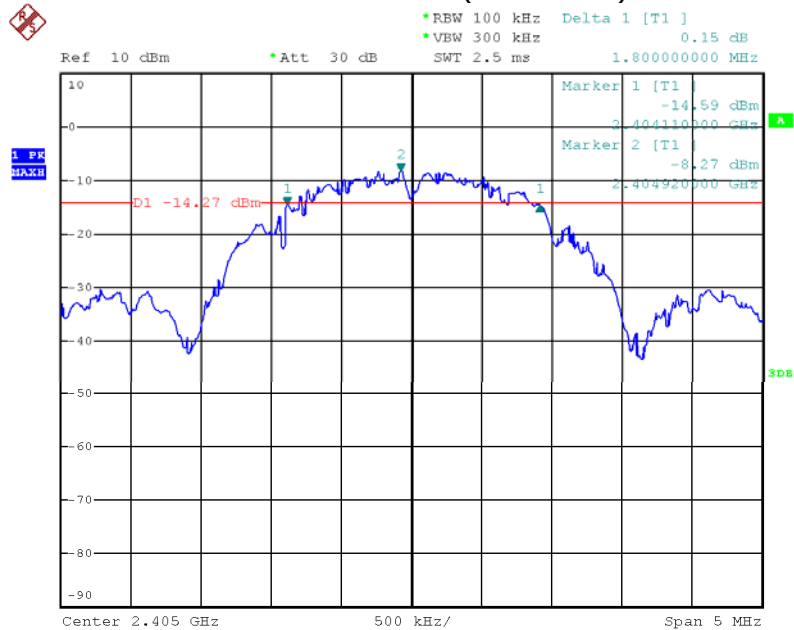
6 dB Bandwidth > 500kHz

Test Data :

Channel	Frequency [MHz]	6 dB Bandwidth [MHz]	Result
Low	2 405	1.800	Complies
Middle	2 445	1.630	Complies
High	2 480	1.700	Complies

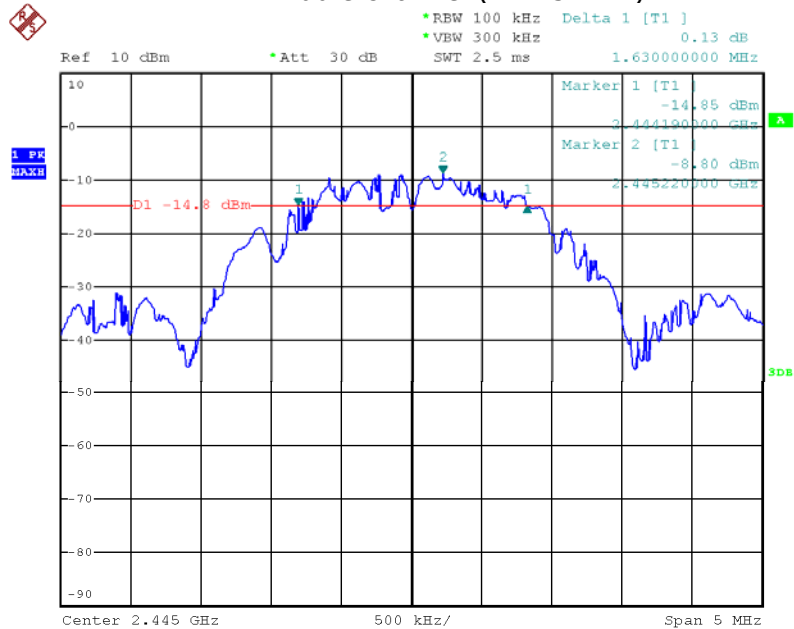
See next pages for actual measured spectrum plots.

6dB Bandwidth Low channel (2 405 MHz)



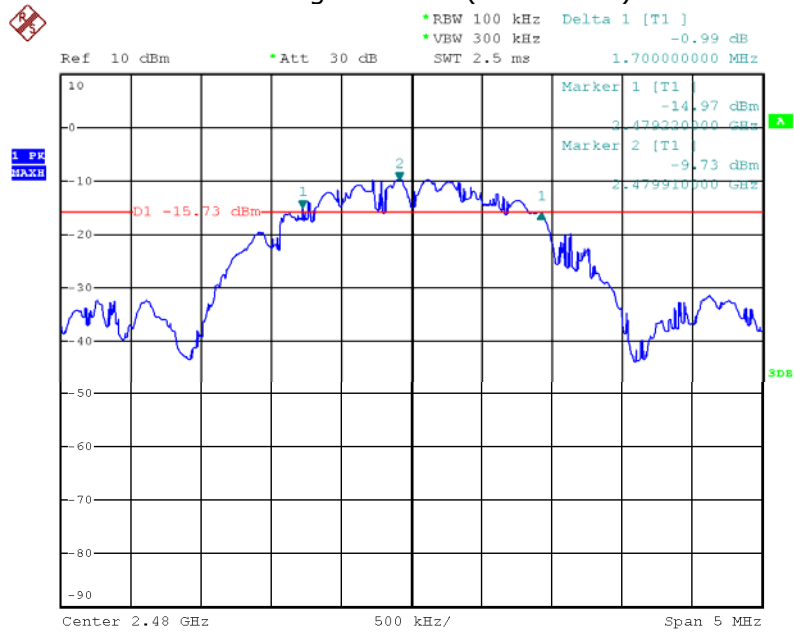
Date: 24.SEP.2017 18:56:10

Middle channel (2 445 MHz)



Date: 24.SEP.2017 18:58:22

High channel (2 480 MHz)



Date: 24.SEP.2017 18:59:55

4.2 Maximum peak Conducted Output Power

Test Procedures(ANSI C63.10-2013 11.9.1)

The following procedure can be used when the maximum available RBW of the instrument is less than the DTS bandwidth:

Test Settings:

Center frequency = the highest, middle and the lowest channels

- a) $RBW \geq DTS \text{ Bandwidth}$
- b) $VBW \geq 3 \times RBW$
- c) $span \geq 3 \times RBW$
- d) Sweep time = auto couple
- e) Detector = peak
- f) Trace mode= max hold
- g) Allow trace to fully stabilize
- h) Use peak marker function to determine the peak amplitude level.

Limit :

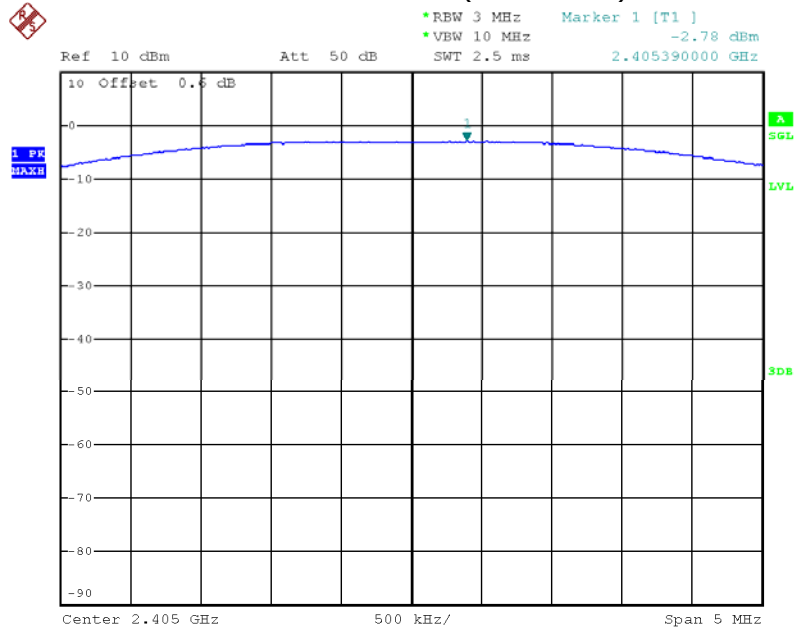
Maximum Output Power < 1 W (30 dBm)

Test Data :

Channel	Frequency [MHz]	Measurement data [dBm]	Limit [dBm]	Result
Low	2 405	-2.78	30	Complies
Middle	2 445	-2.81	30	Complies
High	2 480	-3.42	30	Complies

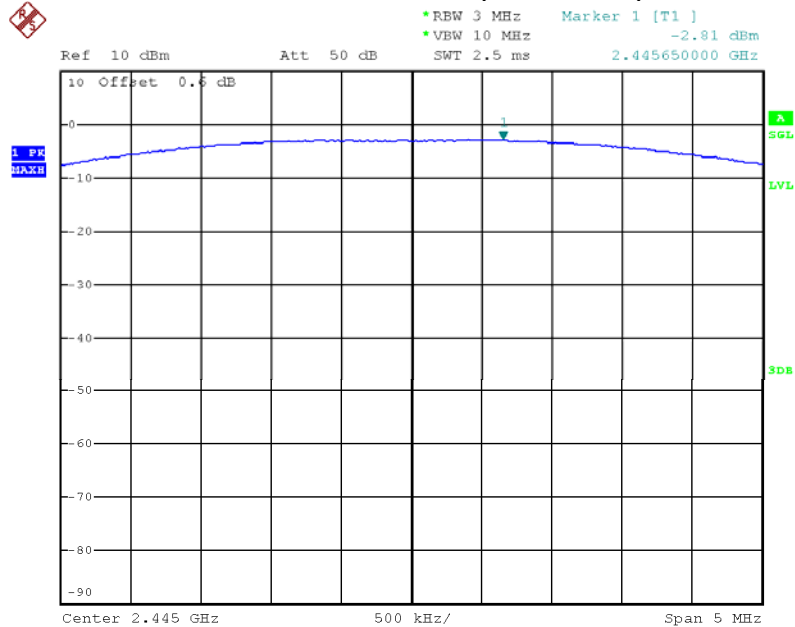
See next pages for actual measured spectrum plots.

Low channel (2 405 MHz)

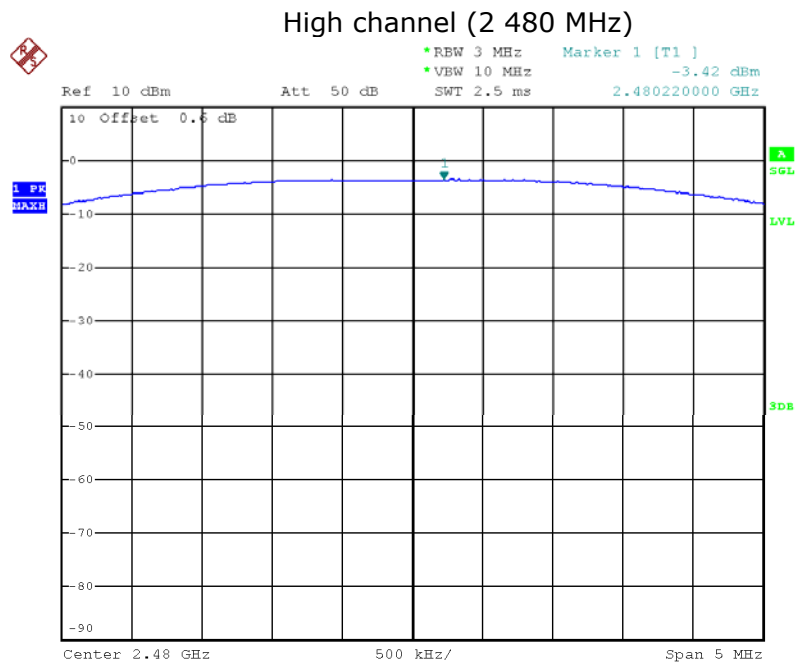


Date: 24.SEP.2017 18:12:36

Middle channel (2 445 MHz)



Date: 24.SEP.2017 18:32:24



Date: 24.SEP.2017 18:34:41

4.3 Power Spectral Density

Test Procedures(ANSI C63.10-2013 11.10.2)

This procedure shall be used if maximum peak conducted output power was used to demonstrate compliance.

Test Settings:

Center frequency = the highest, middle and the lowest channels

- a) RBW : $3 \text{ kHz} \leq \text{RBW} \leq 100 \text{ kHz}$
- b) VBW $\geq 3 \times \text{RBW}$
- c) span $\geq 1.5 \times \text{DTS bandwidth}$
- d) Sweep time = auto couple
- e) Detector = peak
- f) Trace mode= max hold
- g) Allow trace to fully stabilize
- h) Use the peak marker function to determine the maximum amplitude level within the RBW.

Limit :

Power Spectral Density < 8 dBm @ 3 kHz BW

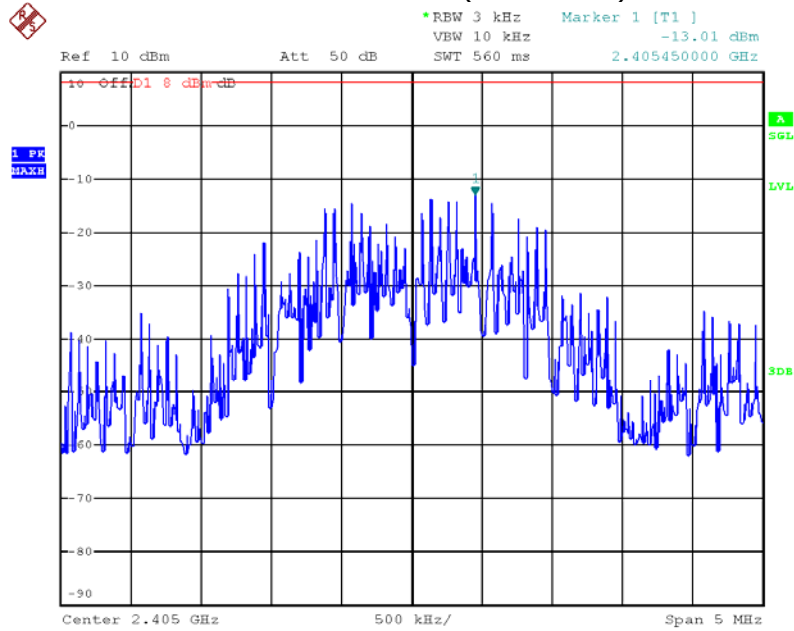
Test Data :

Test mode

Channel	Frequency [MHz]	Measurement data [dBm]	Limit [dBm]	Result
Low	2 405	-13.01	8	Complies
Middle	2 445	-12.94	8	Complies
High	2 480	-13.88	8	Complies

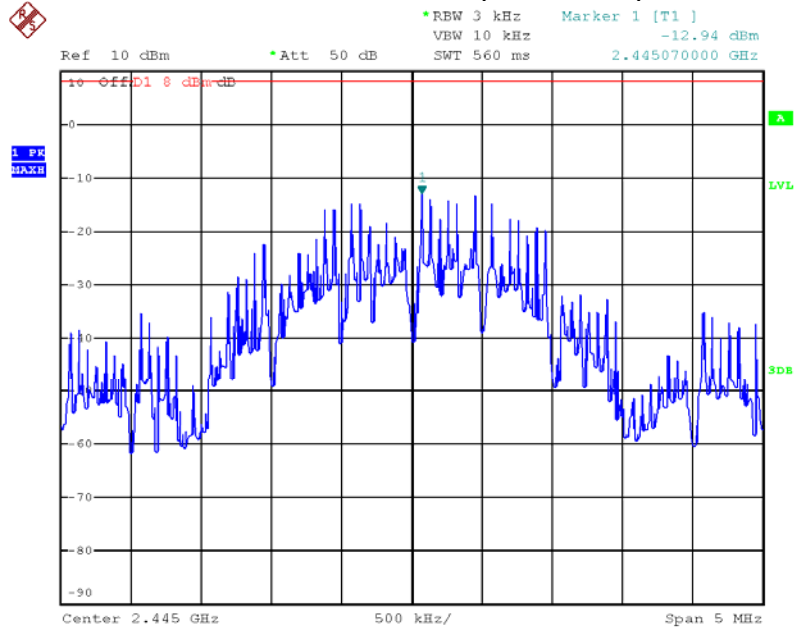
See next pages for actual measured spectrum plots.

Low channel (2 405 MHz)



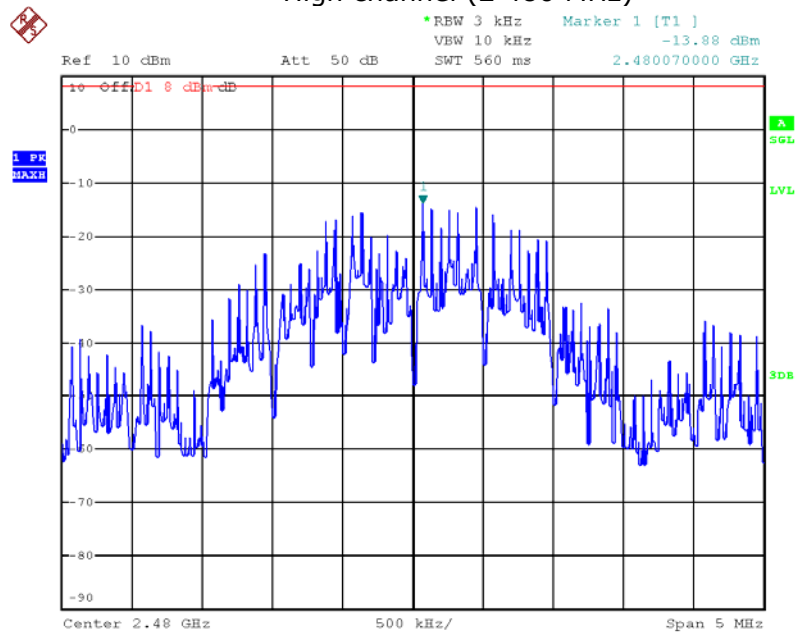
Date: 24.SEP.2017 18:48:45

Middle channel (2 445 MHz)



Date: 24.SEP.2017 18:50:37

High channel (2 480 MHz)



Date: 24.SEP.2017 18:51:23

4.4 Band Edge & Conducted Spurious emission

Test Procedures(ANSI C63.10-2013 11.11.3)

The Unwanted emission from the EUT were measured according to the dictates PKPSD measurement procedure in section 11.11 of ANSI C63.10-2013.

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated device is operating, the RF power that is produced shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided that the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of root-mean-square averaging over a time interval, as permitted under Section 5.4(4), the attenuation required shall be 30 dB instead of 20 dB. Attenuation below the general field strength limits specified in RSS-Gen is not required.

Test Settings:

Center frequency = the highest, middle and the lowest channels

- | | |
|---|-----------------------------|
| a) RBW = 100 kHz | b) VBW $\geq 3 \times$ RBW |
| c) Detector = peak | d) Sweep time = auto couple |
| e) Trace mode= max hold | |
| f) Allow trace to fully stabilize | |
| g) Use the peak marker function to determine the maximum amplitude level. | |

Limit :

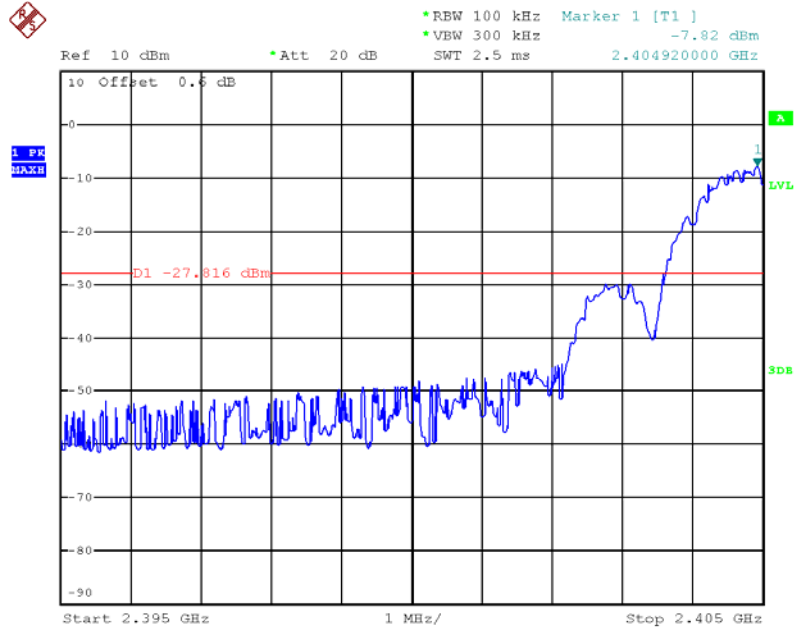
Emission level < 20 dBc

Test results: Complies

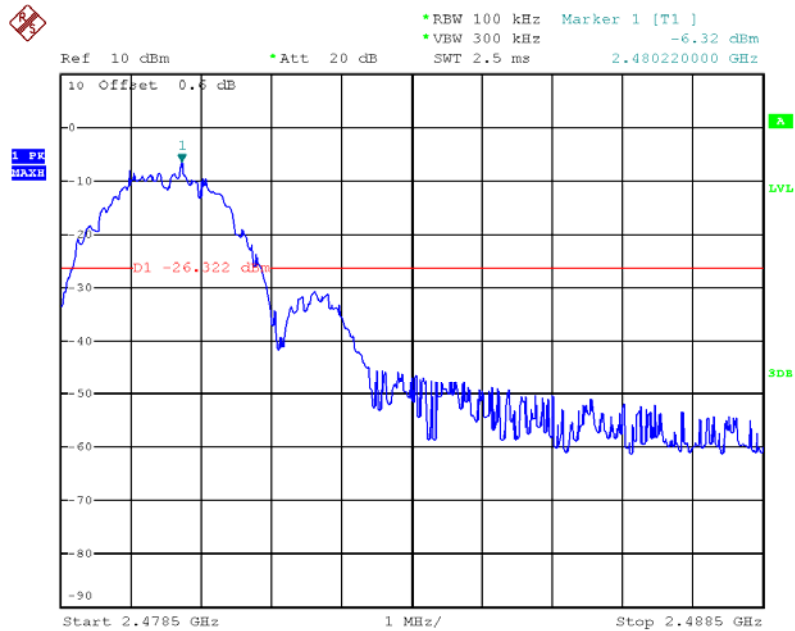
- All conducted emission in any 100kHz bandwidth outside of the spread spectrum band was at least 20dB lower than the highest in-band spectral density. Therefore the applying equipment meets the requirement.

See next pages for actual measured spectrum plots.

Band-edge



Date: 24.SEP.2017 18:45:06

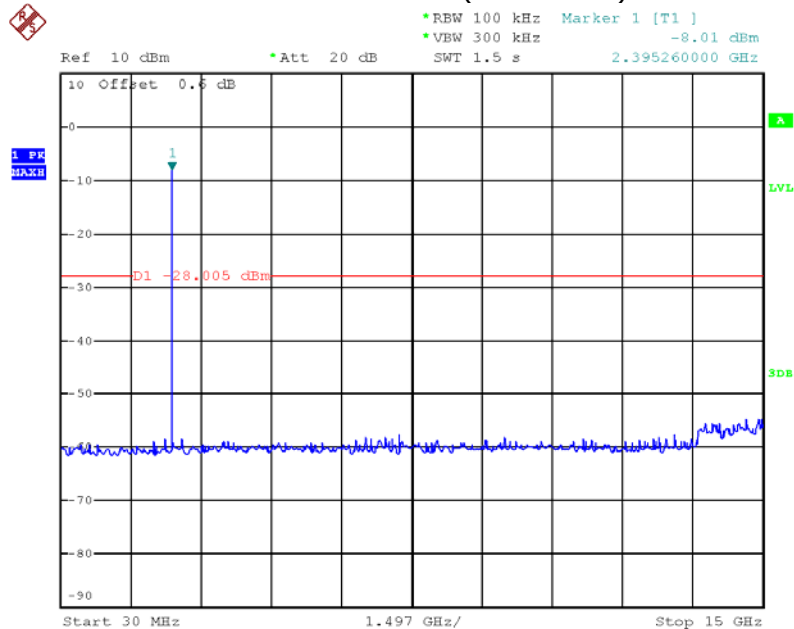


Date: 24.SEP.2017 18:45:58

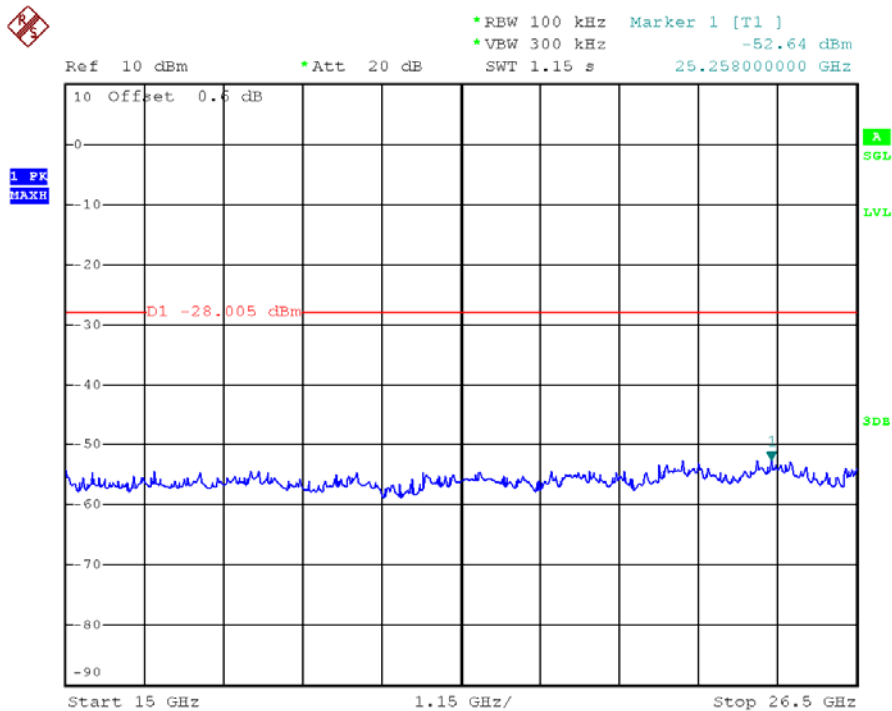
Conducted Spurious emission

Test mode : Transmit

Low channel (2 405 MHz)

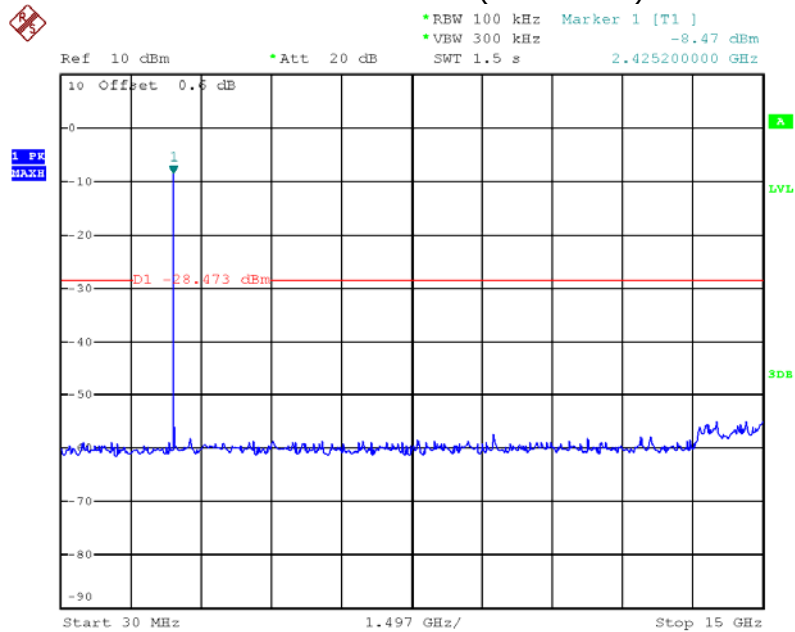


Date: 24.SEP.2017 18:40:41

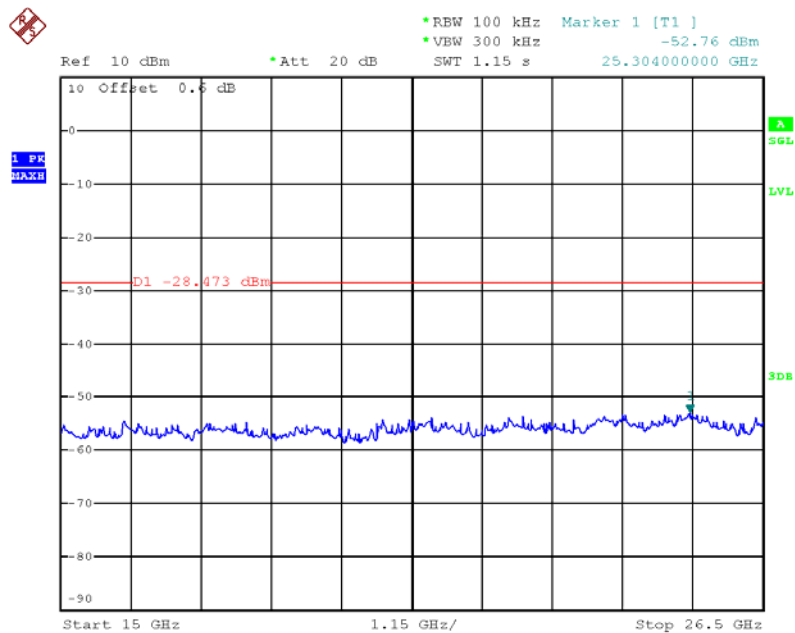


Date: 24.SEP.2017 18:40:55

Middle channel (2 445 MHz)

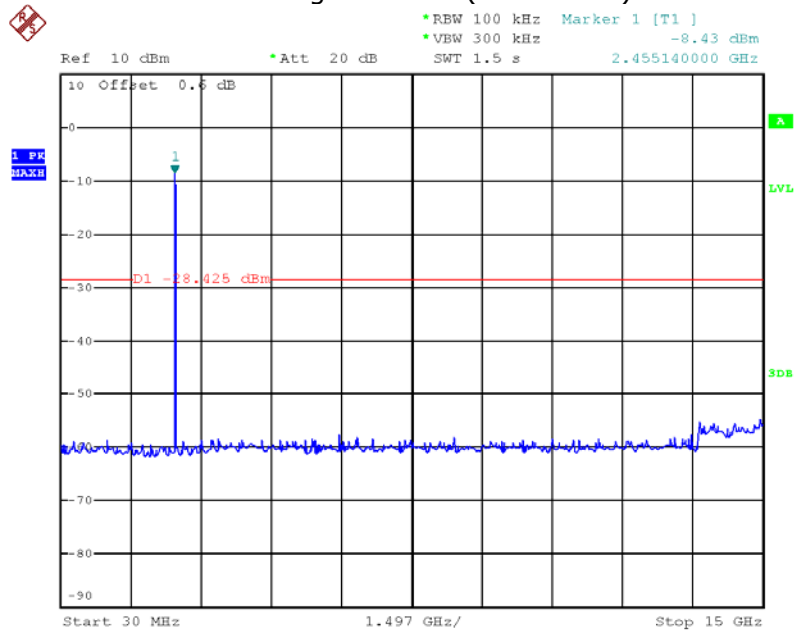


Date: 24.SEP.2017 18:41:43

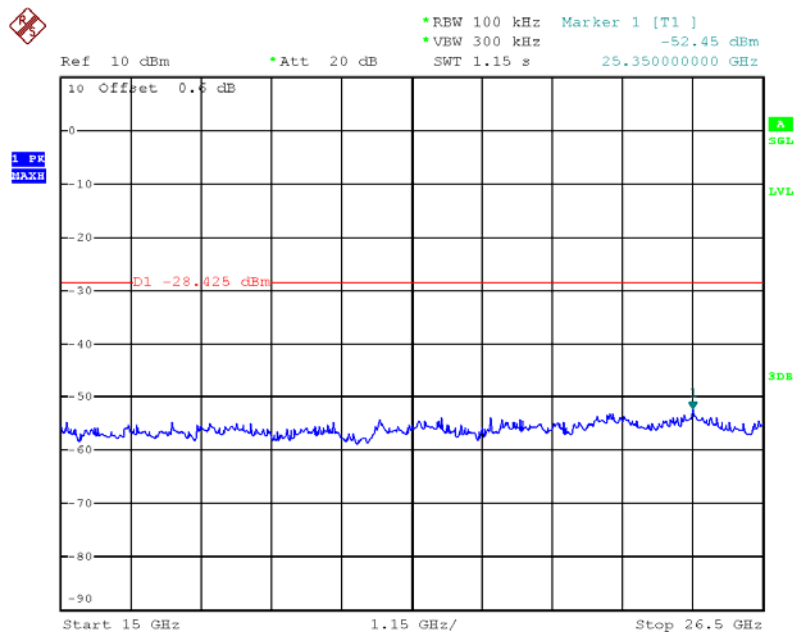


Date: 24.SEP.2017 18:41:57

High channel (2 480 MHz)



Date: 24.SEP.2017 18:42:33



Date: 24.SEP.2017 18:42:47

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4.5 Radiated Emission

Test Location

- ☒ 10 m SAC (test distance : ☐ 10 m, ☒ 3 m)
☒ 3 m SAC (test distance : 3 m)

Test Procedures

- 1) In the frequency range of 9 kHz to 30 MHz, magnetic field is measured with Loop Antenna. The center of the Loop Test Antenna is 1m above the ground. During the measurement the Loop Test Antenna rotates about its vertical axis for maximum response at each azimuth about the EUT.
- 2) In the frequency range above 30 MHz, Bi-Log Test Antenna(30 MHz to 1 GHz) and Horn Test Antenna(above 1 GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is carried from 1m to 4m above the ground to determine the maximum value of the field strength. The emissions levels at both horizontal and vertical polarizations should be tested.

Instrument Settings

Frequency Range = 9 kHz ~ 25 GHz (2.4 GHz 10th harmonic)

- a) RBW = 1 MHz for $f \geq 1$ GHz, 100 kHz for $f < 1$ GHz, 9 kHz for $f < 30$ MHz
- b) VBW $\geq$ RBW
- c) Sweep time = auto couple

Limit :

Unwanted emissions that do not fall within the restricted frequency bands of Table 1 shall comply either with the limits specified in the applicable RSS or with those specified in this RSS-Gen.

Table 1. Restricted Frequency Bands *

MHz	MHz	MHz	MHz	MHz	GHz
0.09-0.11	8.37626-8.38675	73-74.6	399.9-410	2690-2900	10.6-12.7
¹ 0.495-0.505	8.41425-8.41475	74.8-75.2	608-614	3260-3267	13.25-13.4
2.1735-2.1905	12.29-12.293	108-121.94	960-1240	3332-3339	14.47-14.5
4.125-4.128	12.51975-12.52025	123-138	1300-1427	3345.8-3358	15.35-16.2
4.17725-4.17775	12.57675-12.57725	149.9-150.05	1435-1626.5	3600-4400	17.7-21.4
4.20725-4.20775	13.36-13.41	156.52475-156.52525	1645.5-1646.5	4500-5150	22.01-23.12
6.215-6.218	16.42-16.423	156.7-156.9	1660-1710	5350-5460	23.6-24
6.26775-6.26825	16.69475-16.69525	162.0125-167.17	1718.8-1722.2	7250-7750	31.2-31.8
6.31175-6.31225	16.80425-16.80475	167.72-173.2	2200-2300	8025-8500	36.43-36.5
8.291-8.294	25.5-25.67	240-285	2310-2390	9000-9200	² Above 38.6
8.362-8.366	37.5-38.25	322-335.4	2483.5-2500	9300-9500	

*Certain frequency bands listed in Table 6 and in band above 38.6 GHz are designated for licence-exempt applications. These frequency bands and the requirements that apply to the devices are set out in the 200- and 300-series of RSSs, such as RSS-210 and RSS-310, which contain the requirements that apply to licence-exempt radio apparatus.

Except when the requirements applicable to a given device state otherwise, emissions from licence-exempt transmitters shall comply with the field strength limits shown in Table 2. Additionally, the level of any transmitter emission shall not exceed the level of the transmitter's fundamental emission.

Table 2. General Field Strength Limits for Licence-Exempt Transmitters

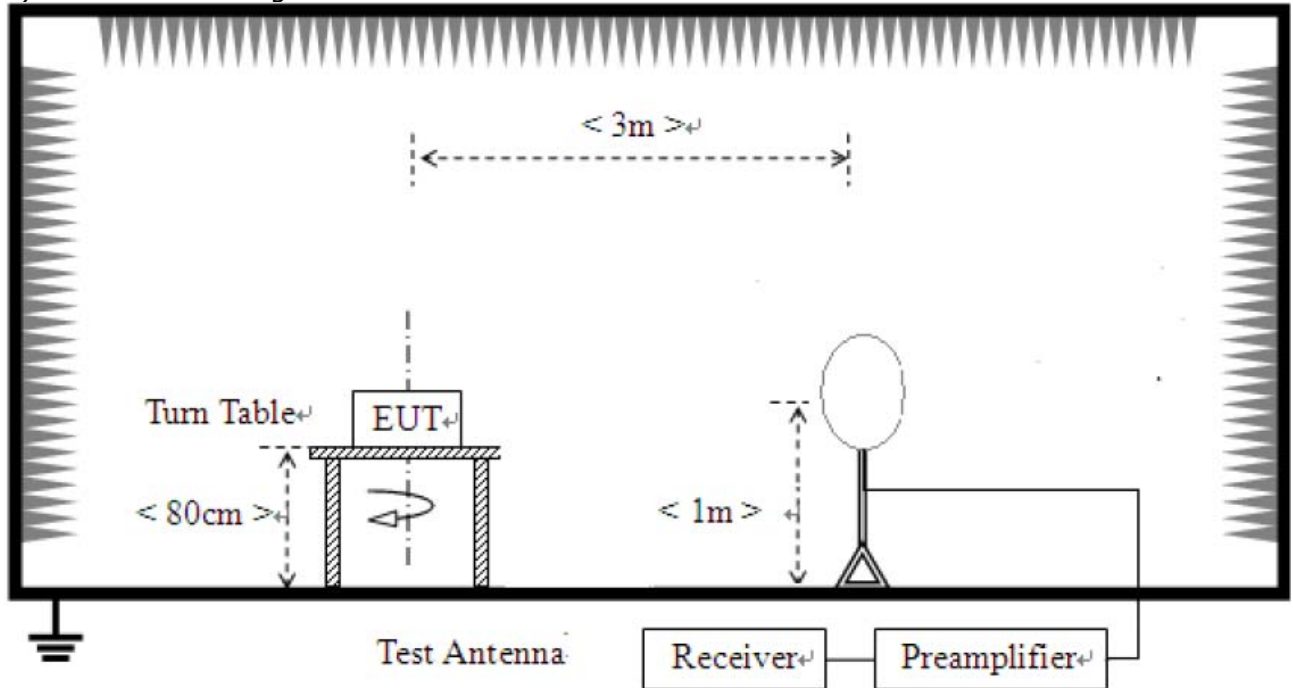
Frequency(MHz)	Field Strength uV/m@3m	Field Strength dBuV/m@3m	Deasurement Distance (meters)
0.009-0.490	2400/F(kHz)	-	300
0.490-1.705	24000/F(kHz)	-	30
1.705-30	30	-	30
30-88	100	40	3
88-216	150	43.5	3
216-960	200	46	3
Above 960	500	54	3

Note :

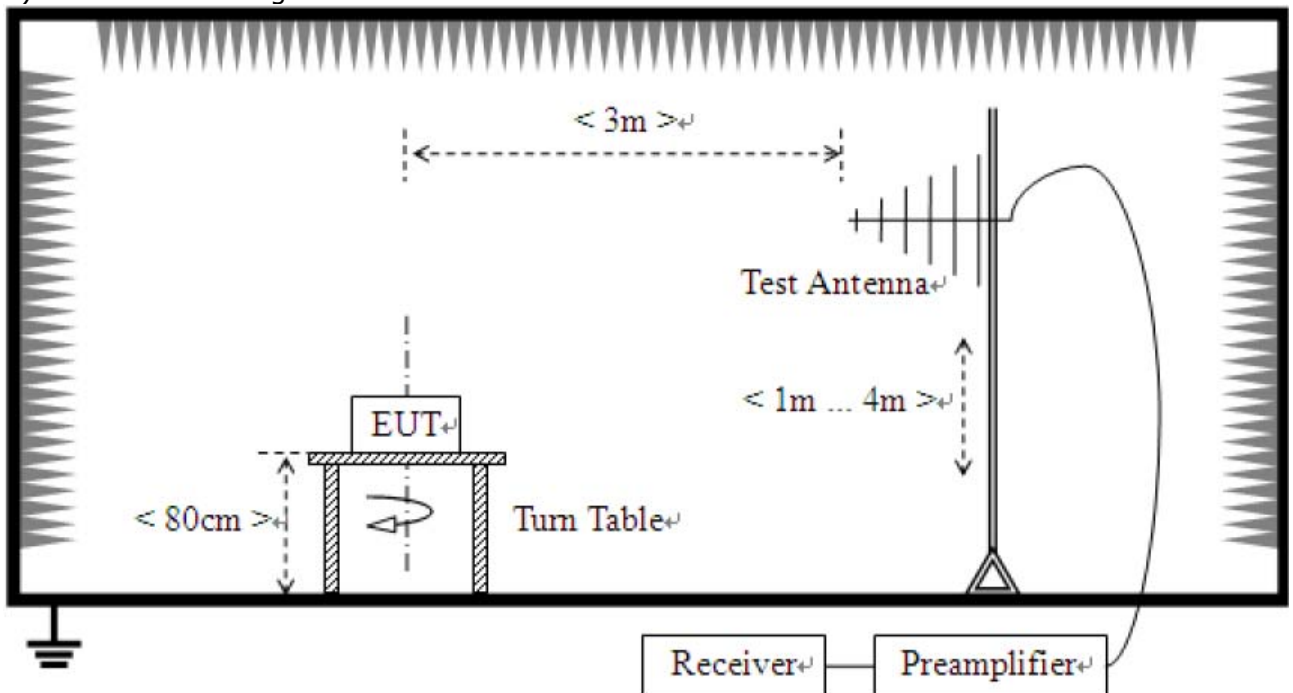
- 1) For above 1 GHz, the emission limit in this paragraph is based on measurement instrumentation employing an average detector, measurement using instrumentation with a peak detector function, corresponding to 20 dB above the maximum permitted average limit.
- 2) For above 1 GHz, limit field strength of harmonics : 54 dBuV/m@3m (AV) and 74 dBuV/m@3m (PK)
- 3) For measurement above 1GHz, the resolution bandwidth is set to 1 MHz and video bandwidth is set to 1 MHz for peak measurement and 10 Hz for average measurement.(Duty Cycle is > 98%,)
- 4) Duty Cycle is < 98%, VBW setting will need to > 1/T.

Test Setup:

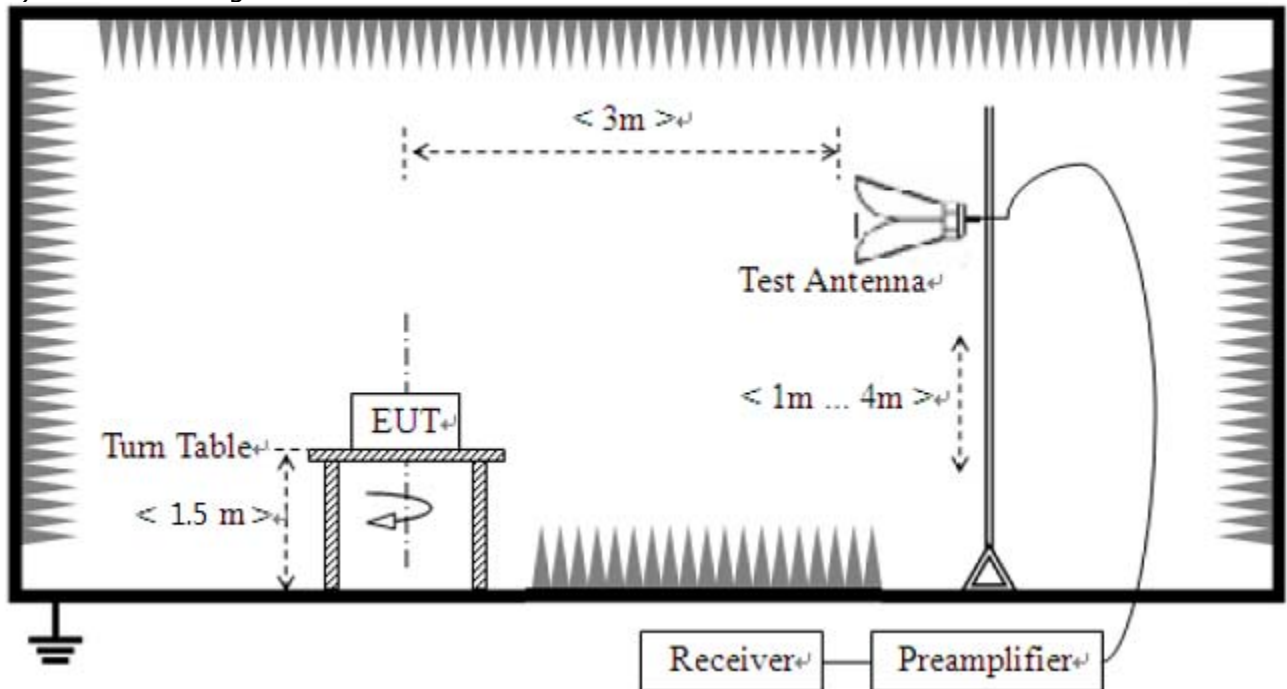
- 1) For field strength of emissions from 9 kHz to 30 MHz



- 2) For field strength of emissions from 30 MHz to 1 GHz



3) For field strength of emissions above 1 GHz



Test results

1) 9 kHz to 30 MHz

The requirements are:

☒ Complies

Frequency (MHz)	Measured Data (dBuV/m)	Margin (dB)	Remark
-	-	-	See note

Note :

The amplitude of spurious emissions that are attenuated by more than 20 dB below the permissible value has no need to be reported.

Distance extrapolation factor = $40 \log (\text{specific distance} / \text{test distance})$ (dB)

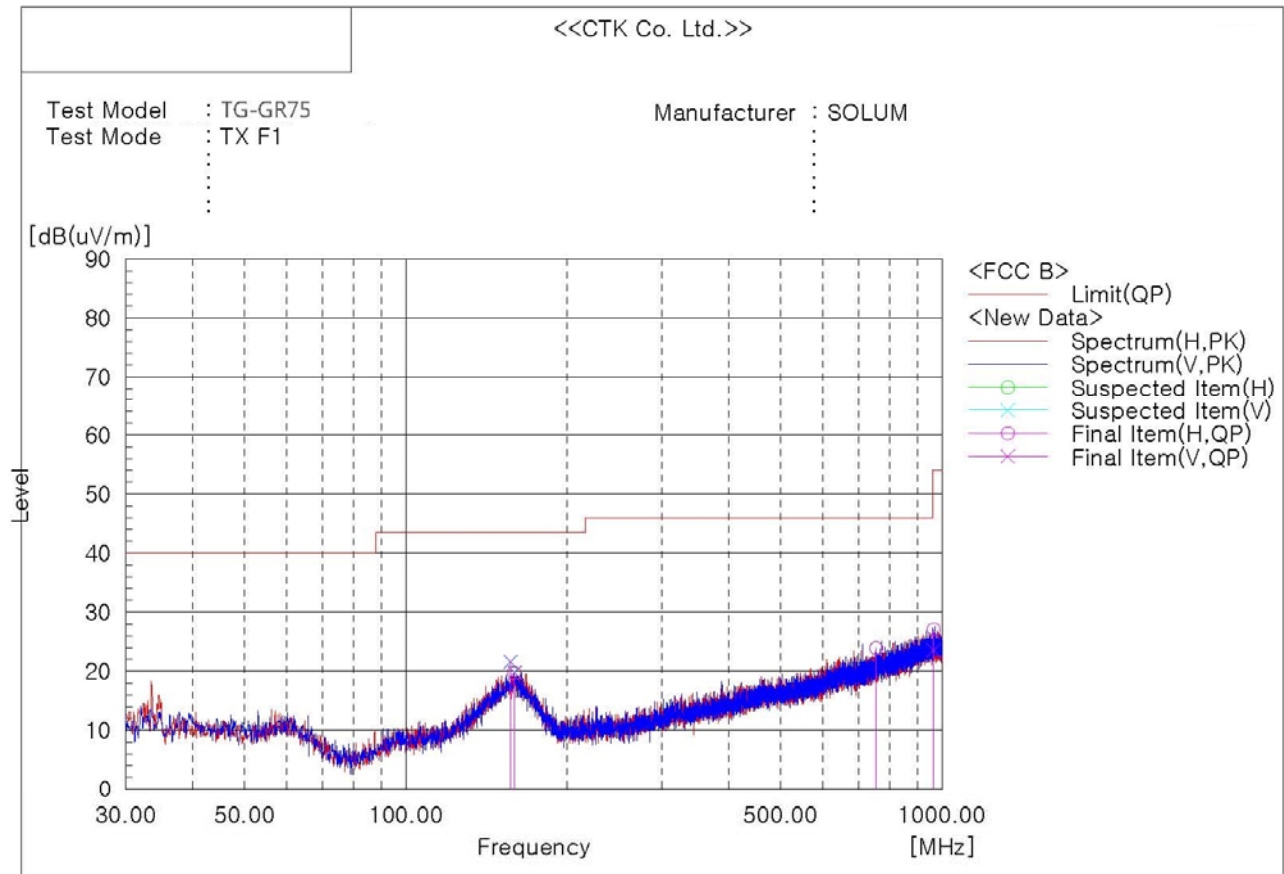
2) 30 MHz to 1 GHz

Test mode : Transmit, Lowest Channel(Worst case)

The requirements are:

☒ Complies

Test Data



Final Result

No.	Frequency [MHz]	(P)	Reading QP [dB(uV)]	c.f [dB(1/m)]	Result QP [dB(uV/m)]	Limit QP [dB(uV/m)]	Margin QP [dB]	Height [cm]	Angle [deg]
1	159.131	H	26.4	-6.7	19.7	43.5	23.8	174.0	176.5
2	753.863	H	28.2	-4.3	23.9	46.0	22.1	174.0	139.3
3	965.201	H	28.4	-1.3	27.1	54.0	26.9	174.0	288.6
4	965.201	V	24.9	-1.3	23.6	54.0	30.4	174.2	177.9
5	156.828	V	28.5	-6.9	21.6	43.5	21.9	174.2	177.9
6	159.616	V	26.5	-6.7	19.8	43.5	23.7	174.2	177.9

Remark :

1. The Unwanted emission was measured in the following position: EUT stand-up position(Z axis), lie-down position(X,Y axis). The worst emission was found in lie-down position(X axis) and the worst case was recorded.
2. Result = Reading + c.f(Correction factor)
3. Correction factor = Antenna factor + Cable loss + 6 dB attenuator - Amp Gain
4. This data is the Peak(PK) value.

3) above 1 GHz

The requirements are:

☒ Complies

Test Data

Low(2 405 MHz)

Frequency [MHz]	(P)	(m)	Reading AV / PK [dBuV / m]	Correction Factor	Result AV / PK [dBuV / m]	Limit AV / PK [dBuV / m]	Margin AV / PK [dB]
2390.00	V	1.5	32.36 / 45.65	-4.01	28.28 / 43.58	54.00 / 74.00	25.72 / 30.42
4809.03	V	1.5	36.37 / 46.21	2.80	39.13 / 48.97	54.00 / 74.00	14.87 / 25.03

Mid(2 445 MHz)

Frequency [MHz]	(P)	(m)	Reading AV / PK [dBuV / m]	Correction Factor	Result AV / PK [dBuV / m]	Limit AV / PK [dBuV / m]	Margin AV / PK [dB]
4889.00	V	1.5	37.25 / 47.13	2.80	40.00 / 49.88	54.00 / 74.00	14.00 / 24.12

High(2 480 MHz)

Frequency [MHz]	(P)	(m)	Reading AV / PK [dBuV / m]	Correction Factor	Result AV / PK [dBuV / m]	Limit AV / PK [dBuV / m]	Margin AV / PK [dB]
2483.50	V	1.5	57.23 / 64.65	-3.90	53.33 / 60.75	54.00 / 74.00	0.67 / 13.25
4989.05	V	1.5	40.84 / 49.08	1.90	42.75 / 50.99	54.00 / 74.00	11.25 / 23.01

Remarks

1. The Unwanted emission was measured in the following position: EUT stand-up position(Z axis), lie-down position(X,Y axis). The worst emission was found in lie-down position(X axis) and the worst case was recorded.

APPENDIX A – Test Equipment Used For Tests

	Name of Equipment	Manufacturer	Model No.	Serial No.	Date of Calibration	Due Date
1	Signal Analyzer	R&S	FSP30	100994	2016-11-01	2017-11-01
2	MXG Vector Signal Generator	Agilent	N5182A	MY50143486	2017-02-01	2018-02-03
3	EMI Test Receiver	Rohde & Schwarz	ESCI7	100814	2016-11-01	2017-11-01
4	Bilog Antenna	Schaffner	CBL6111C	2551	2016-05-13	2018-05-13
5	Active Loop Antenna	SCHWARZBECK	FMZB 1513	1513-126	2016-05-25	2018-05-25
6	6dB Attenuator	R&S	DNF	272.4110.50-2	2016-11-01	2017-11-01
7	6dB Attenuator	R&S	DNF	272.4110.50-1	2017-02-03	2018-02-03
8	AMPLIFIER	SONOMA	310	291721	2017-02-02	2018-02-02
9	EMI Test Receiver	Rohde & Schwarz	ESU40	100336	2017-05-12	2018-05-12
10	Preamplifier	Agilent	8449B	3008A02011	2016-12-01	2017-12-01
11	Horn Antenna	ETS-Lindgren	3115	00078895	2017-04-25	2019-04-25
12	Horn Antenna	ETS-Lindgren	3116	00062916	2017-04-25	2019-04-25
13	Active Loop Antenna	SCHWARZBECK	FMZB 1513	1513-125	2017-05-16	2018-05-16
14	Band Reject Filter	Micro Tronics	BRM50702	G233	2017-02-03	2018-02-03
15	DC Power Supply	Agilent	E3632A	MY40011638	2016-11-01	2017-11-01

APPENDIX B – EUT Photographs

